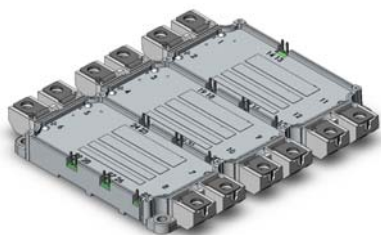


# SEMiX553GD128Dc



SEMiX® 33c

## SPT IGBT Modules

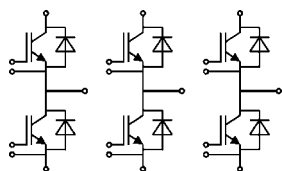
### SEMiX553GD128Dc

#### Features

- Homogeneous Si
- SPT = Soft-Punch-Through technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability
- UL recognised file no. E63532

#### Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders up to 20 kHz

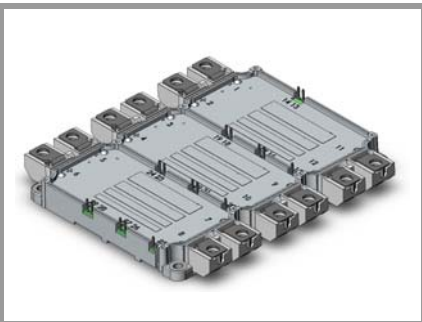


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Absolute Maximum Ratings				
Symbol	Conditions	Values	Unit	
<b>IGBT</b>				
$V_{CES}$		1200	V	
$I_C$	$T_j = 150\text{ °C}$	$T_c = 25\text{ °C}$	533	A
		$T_c = 80\text{ °C}$	379	A
$I_{Cnom}$		300	A	
$I_{CRM}$	$I_{CRM} = 2 \times I_{Cnom}$	600	A	
$V_{GES}$		-20 ... 20	V	
$t_{psc}$	$V_{CC} = 600\text{ V}$ $V_{GE} \leq 20\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_j = 125\text{ °C}$	10	$\mu\text{s}$
$T_j$		-40 ... 150	$^{\circ}\text{C}$	
<b>Inverse diode</b>				
$I_F$	$T_j = 150\text{ °C}$	$T_c = 25\text{ °C}$	421	A
		$T_c = 80\text{ °C}$	289	A
$I_{Fnom}$		300	A	
$I_{FRM}$	$I_{FRM} = 2 \times I_{Fnom}$	600	A	
$I_{FSM}$	$t_p = 10\text{ ms, sin } 180^{\circ}, T_j = 25\text{ °C}$	2300	A	
$T_j$		-40 ... 150	$^{\circ}\text{C}$	
<b>Module</b>				
$I_{t(RMS)}$		600	A	
$T_{stg}$		-40 ... 125	$^{\circ}\text{C}$	
$V_{isol}$	AC sinus 50Hz, $t = 1\text{ min}$	4000	V	

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
<b>IGBT</b>					
$V_{CE(sat)}$	$I_C = 300\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25\text{ °C}$	1.9	2.35	V
		$T_j = 125\text{ °C}$	2.1	2.55	V
$V_{CE0}$		$T_j = 25\text{ °C}$	1	1.15	V
		$T_j = 125\text{ °C}$	0.9	1.05	V
$r_{CE}$	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$	3.0	4.0	$\text{m}\Omega$
		$T_j = 125\text{ °C}$	4.0	5.0	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 12\text{ mA}$	4.5	5	6.5	V
$I_{CES}$	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_j = 25\text{ °C}$	0.1	0.3	$\text{mA}$
		$T_j = 125\text{ °C}$			$\text{mA}$
$C_{ies}$	$V_{CE} = 25\text{ V}$		28.3		nF
$C_{oes}$	$V_{GE} = 0\text{ V}$		1.86		nF
$C_{res}$			1.17		nF
$Q_G$	$V_{GE} = -8\text{ V...} + 15\text{ V}$		2880		nC
$R_{Gint}$	$T_j = 25\text{ °C}$		1.33		$\Omega$
$t_{d(on)}$	$V_{CC} = 600\text{ V}$	$T_j = 125\text{ °C}$	185		ns
$t_r$	$I_C = 300\text{ A}$	$T_j = 125\text{ °C}$	65		ns
		$T_j = 125\text{ °C}$	27		mJ
$E_{on}$	$R_{G on} = 3\text{ }\Omega$	$T_j = 125\text{ °C}$	635		ns
$t_{d(off)}$	$R_{G off} = 3\text{ }\Omega$	$T_j = 125\text{ °C}$	80		ns
$t_f$		$T_j = 125\text{ °C}$	33		mJ
$E_{off}$		$T_j = 125\text{ °C}$			
$R_{th(j-c)}$	per IGBT		0.061		K/W

# SEMiX553GD128Dc



SEMiX® 33c

## SPT IGBT Modules

### SEMiX553GD128Dc

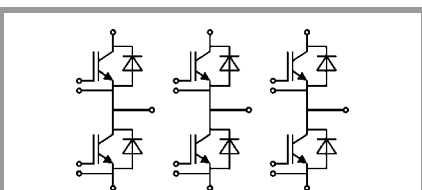
#### Features

- Homogeneous Si
- SPT = Soft-Punch-Through technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability
- UL recognised file no. E63532

#### Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders up to 20 kHz

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
<b>Inverse diode</b>						
$V_F = V_{EC}$	$I_F = 300\text{ A}$ $V_{GE} = 0\text{ V}$ chip	$T_j = 25\text{ °C}$		2.0	2.50	V
		$T_j = 125\text{ °C}$		1.8	2.3	V
$V_{F0}$		$T_j = 25\text{ °C}$	0.75	1.1	1.45	V
		$T_j = 125\text{ °C}$	0.5	0.85	1.2	V
$r_F$		$T_j = 25\text{ °C}$	2.5	3.0	3.5	mΩ
		$T_j = 125\text{ °C}$	2.7	3.2	3.7	mΩ
$I_{RRM}$	$I_F = 300\text{ A}$	$T_j = 125\text{ °C}$		325		A
$Q_{rr}$	$di/dt_{off} = 5400\text{ A/}\mu\text{s}$	$T_j = 125\text{ °C}$		46		μC
$E_{rr}$	$V_{GE} = -15\text{ V}$ $V_{CC} = 600\text{ V}$	$T_j = 125\text{ °C}$		17		mJ
$R_{th(j-c)}$	per diode				0.11	K/W
<b>Module</b>						
$L_{CE}$				20		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_C = 25\text{ °C}$		0.7		mΩ
		$T_C = 125\text{ °C}$		1		mΩ
$R_{th(c-s)}$	per module			0.014		K/W
$M_s$	to heat sink (M5)		3		5	Nm
$M_t$		to terminals (M6)	2.5		5	Nm
						Nm
$w$					900	g
<b>Temperatur Sensor</b>						
$R_{100}$	$T_c = 100\text{ °C}$ ( $R_{25} = 5\text{ k}\Omega$ )			$493 \pm 5\%$		Ω
$B_{100/125}$	$R_{(T)} = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$ ; $T[\text{K}]$ ;			$3550 \pm 2\%$		K



GD

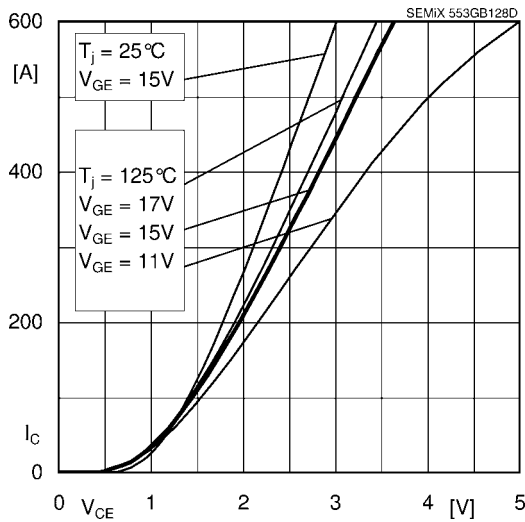


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'+EE'}$

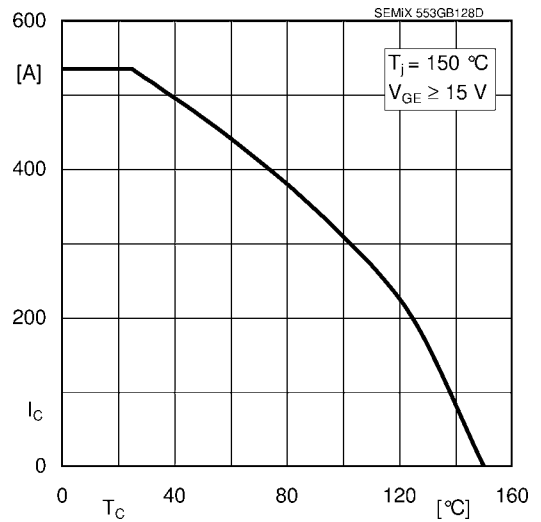


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

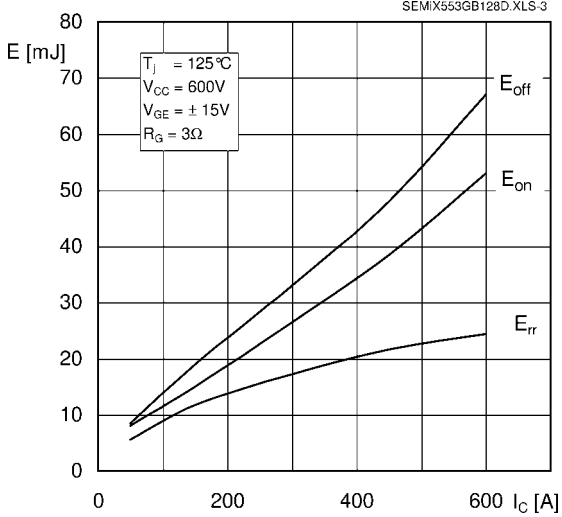


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

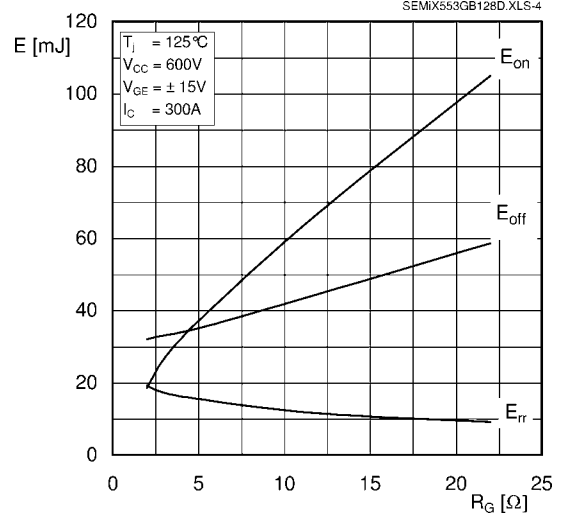


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

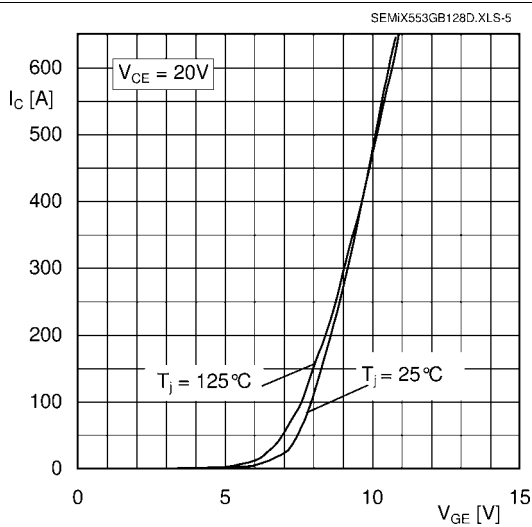


Fig. 5: Typ. transfer characteristic

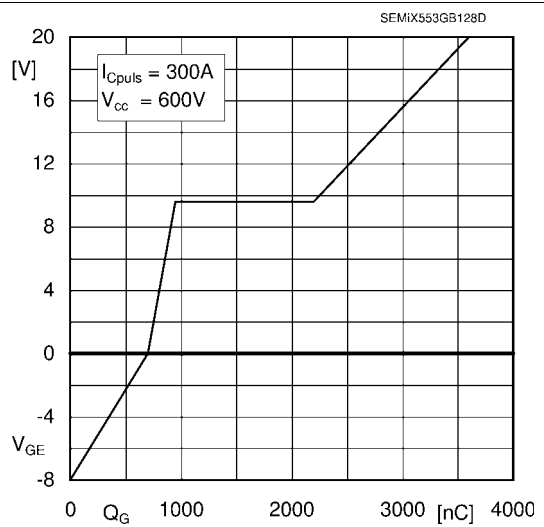
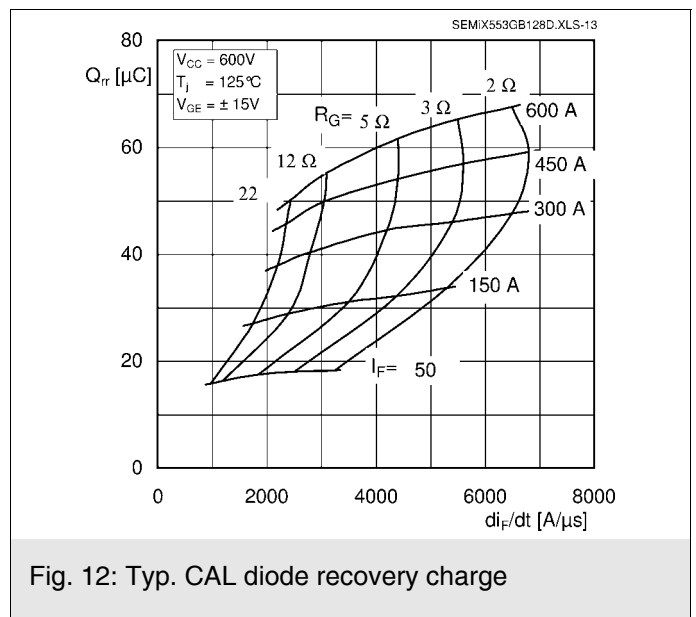
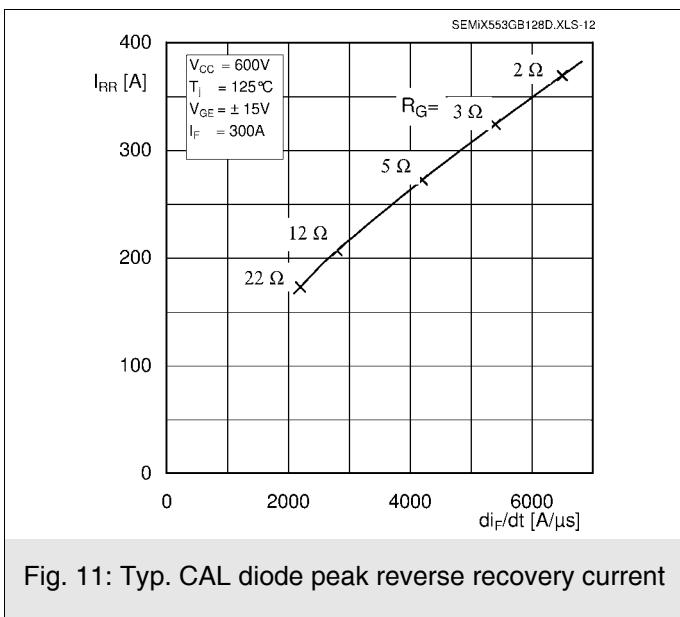
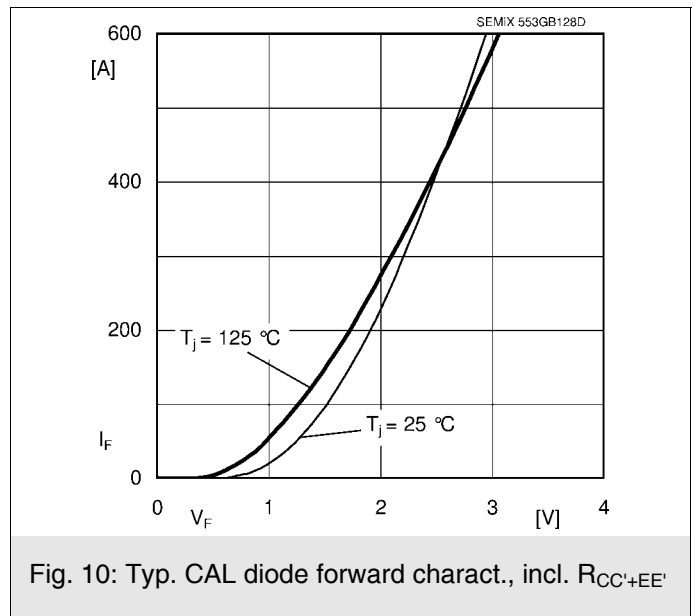
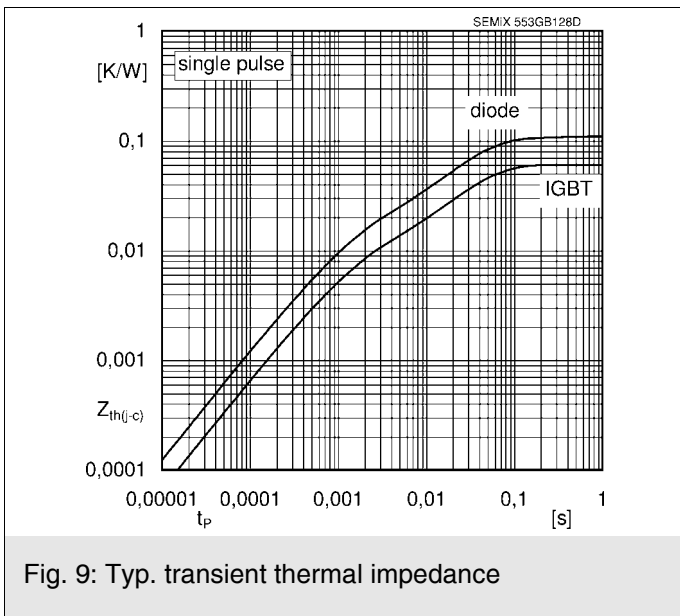
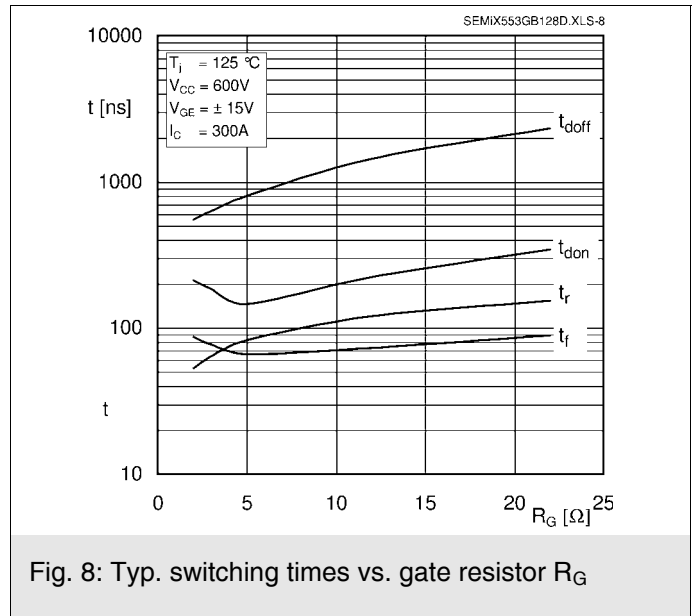
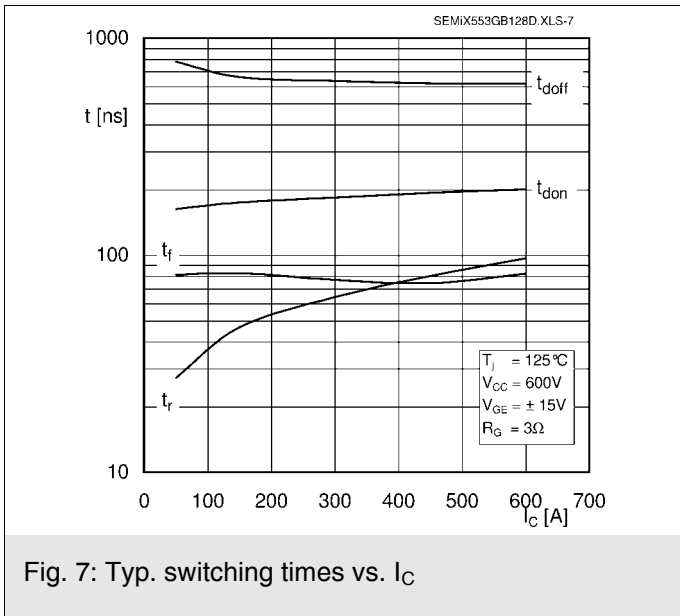
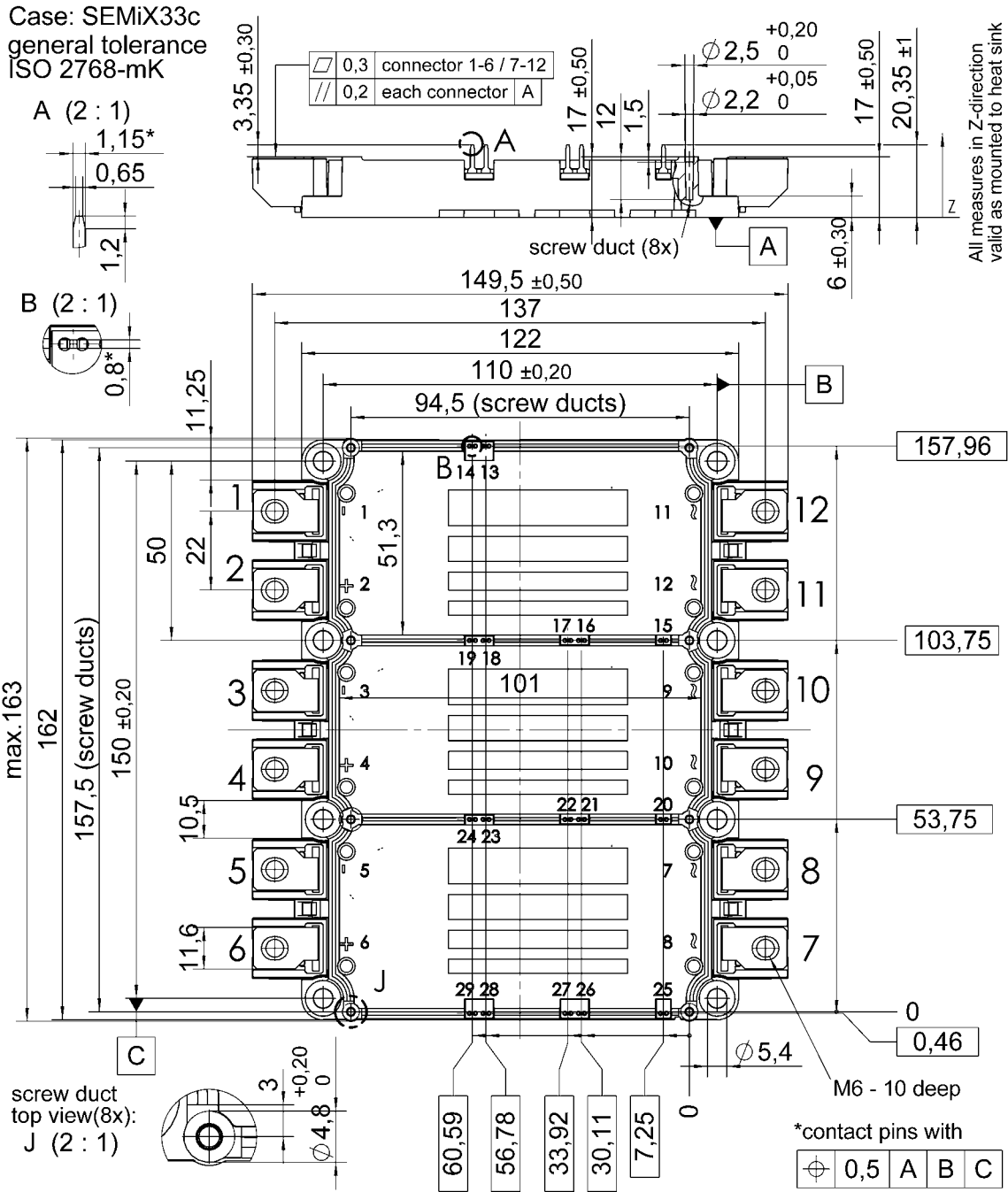


Fig. 6: Typ. gate charge characteristic

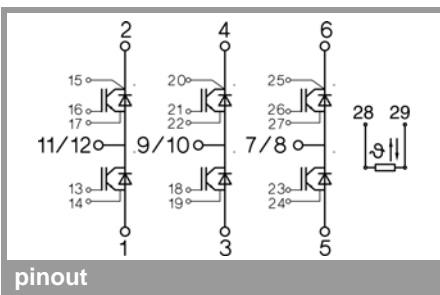


# SEMiX553GD128Dc

Case: SEMiX33c  
 general tolerance  
 ISO 2768-mK



SEMiX 33c



pinout

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.